

# FDFMA3N109

# Integrated N-Channel PowerTrench® MOSFET and Schottky Diode

### **General Description**

This device is designed specifically as a single package solution for a boost topology in cellular handset and other ultra-portable applications. It features a MOSFET with low input capacitance, total gate charge and onstate resistance, and an independently connected schottky diode with low forward voltage and reverse leakage current to maximize boost efficiency.

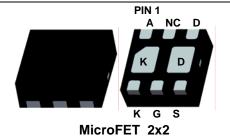
The MicroFET 2x2 package offers exceptional thermal performance for its physical size and is well suited to switching and linear mode applications.

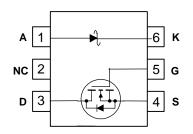
# Features MOSFET:

• 2.9 A, 30 V  $R_{DS(ON)} = 123 \text{ m}\Omega$  @  $V_{GS} = 4.5 \text{ V}$   $R_{DS(ON)} = 140 \text{ m}\Omega$  @  $V_{GS} = 3.0 \text{ V}$   $R_{DS(ON)} = 163 \text{ m}\Omega$  @  $V_{GS} = 2.5 \text{ V}$ 

#### Schottky:

- V<sub>F</sub> < 0.46 V @ 500mA</li>
- Low profile 0.8 mm maximum in the new package MicroFET 2x2 mm
- RoHS Compliant





## Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Symbol	Parameter	Ratings	Units	
V <sub>DS</sub>	Drain-Source Voltage		30	V
V <sub>GS</sub>	Gate-Source Voltage	±12	V	
I <sub>D</sub>	Drain Current – Continuous (T <sub>C</sub> = 25°C, V <sub>GS</sub> = 4.5V)	2.9		
	- Continuous ( $T_C = 25$ °C, $V_{GS} = 2.5$ V)	2.7	Α	
	- Pulsed		10	
P <sub>D</sub>	Power Dissipation for Single Operation	(Note 1a)	1.5	W
	Power Dissipation for Single Operation	(Note 1b)	0.65	VV
$T_J, T_{STG}$	Operating and Storage Temperature	-55 to +150	°C	
$V_{RRM}$	Schottky Repetitive Peak Reverse Voltage	28	V	
Io	Schottky Average Forward Current	1	Α	

### **Thermal Characteristics**

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	83	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1b)	193	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1c)	101	C/VV
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1d)	228	

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
109	FDFMA3N109	7"	8mm	3000 units

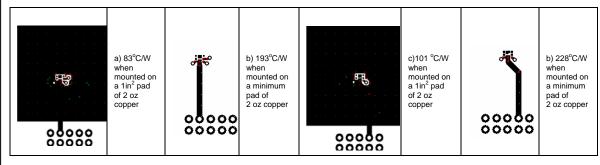
Symbol	Parameter	Test Co	onditions	Min	Тур	Max	Units
Off Char	acteristics	1			I.		
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 V$ , $I_{I}$	<sub>D</sub> = 250 μA	30			V
ΔBV <sub>DSS</sub> ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu A, Ref$	erenced to 25°C		25		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V},  \  \   \  \   \  \   \  \   \  \   \  \ $	$V_{GS} = 0 \text{ V}$			1	μΑ
$I_{GSS}$	Gate-Body Leakage Current	$V_{GS} = \pm 12 \text{ V},        $	$V_{DS} = 0 \text{ V}$			±10	μΑ
On Chara	acteristics						
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, \qquad I_{I}$	<sub>D</sub> = 250 μA	0.4	1.0	1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \mu A, Ref$	erenced to 25°C		-3		mV/°C
		$V_{GS} = 4.5V, I_{D} = 1$			75	123	
		$V_{GS} = 3.0V, I_{D} = 1$			84	140	
R <sub>DS(on)</sub>	Static Drain–Source On–Resistance	$V_{GS} = 2.5V, I_{D} = 1.00$			92	163	$m\Omega$
	OII-Resistance	$V_{GS} = 4.5V, I_D = 3.0V$	2.9A, $T_C = 85^{\circ}C$ 2.7A, $T_C = 150^{\circ}C$		95 138	166 203	-
		$V_{GS} = 3.0V, I_D = 1$		150	268	1	
Dynamic	Characteristics	1 1 3 2 2 3 1 5 1					
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 15 V, \	/ 0 \/		190	220	pF
Coss	Output Capacitance	$\int_{0}^{\infty} \int_{0}^{\infty} \int_{0$	$V_{GS} = U_{V}$		30	40	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 - 1.0 1/11/2			20	30	pF
R <sub>G</sub>	Gate Resistance	$V_{GS} = 0 V$ , f	= 1.0 MHz		4.6	- 00	Ω
	g Characteristics (Note 2)	1 00 0 1,			117		
t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> = 15 V, I <sub>I</sub>	n = 1 A.		6	12	ns
t <sub>r</sub>	Turn–On Rise Time	<b>」</b>	$R_{GEN} = 6 \Omega$		8	16	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	1			12	21	ns
t <sub>f</sub>	Turn-Off Fall Time	1			2	4	ns
Qg	Total Gate Charge	V <sub>DS</sub> = 15 V, I <sub>I</sub>	<sub>D</sub> = 2.9 A,		2.4	3.0	nC
Q <sub>qs</sub>	Gate-Source Charge	$V_{GS} = 4.5 \text{ V}$			0.35	0.0	nC
Q <sub>qd</sub>	Gate-Drain Charge				0.75		nC
		and Martiner	. Detings		00		
I <sub>s</sub>	Durce Diode Characteristics  Maximum Continuous Drain–Source			1		2.9	Α
V <sub>SD</sub>	Drain–Source Diode Forward	I <sub>S</sub> = 2.0 A	Janone		0.9	1.2	,,
• 20	Voltage	$I_S = 2.0 \text{ A}$ $I_S = 1.1 \text{ A}$			0.8	1.2	V
t <sub>rr</sub>	Diode Reverse Recovery Time	I <sub>F</sub> = 2.9 A,			10		ns
Q <sub>rr</sub>	Diode Reverse Recovery Charge	$dI_F/dt = 100 A/\mu s$	;		2		nC
	Diode Characteristics						
			T <sub>J</sub> = 25°C		10	100	μА
$I_R$	Reverse Leakage	V <sub>R</sub> = 28 V	$T_J = 85^{\circ}C$		0.07	4.7	mA
\/	Famuurd Vallage	1 4 4	T <sub>1</sub> = 25°C		0.50	0.57	
$V_{F}$	Forward Voltage	I <sub>F</sub> = 1 A	T <sub>J</sub> = 85°C		0.49	0.60	V
V <sub>F</sub>	Forward Voltage	I <sub>F</sub> = 500 mA	T <sub>J</sub> = 25°C		0.40	0.46	V
٧F	i orwaru voltage	IF = 200 IIIA	$T_J = 85^{\circ}C$		0.36	0.43	V

### **Electrical Characteristics**

T<sub>A</sub> = 25°C unless otherwise noted

#### Notes:

- 1. R<sub>0,JA</sub> is determined with the device mounted on a 1 in<sup>2</sup> oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material. R<sub>0,JC</sub> is guaranteed by design while R<sub>0,JA</sub> is determined by the user's board design.
  - (a) MOSFET R<sub>0JA</sub> = 83°C/W when mounted on a 1in<sup>2</sup> pad of 2 oz copper, 1.5" x 1.5" x 0.062" thick PCB
  - (b) MOSFET  $R_{\theta JA}$  = 193°C/W when mounted on a minimum pad of 2 oz copper
  - (c) Schottky  $R_{\theta JA} = 101^{\circ}\text{C/W}$  when mounted on a 1in<sup>2</sup> pad of 2 oz copper, 1.5" x 1.5" x 0.062" thick PCB
  - (d) Schottky  $R_{\theta JA} = 228^{\circ}\text{C/W}$  when mounted on a minimum pad of 2 oz copper



Scale 1:1 on letter size paper

**2.** Pulse Test: Pulse Width <  $300\mu$ s, Duty Cycle < 2.0%

## **Typical Characteristics**

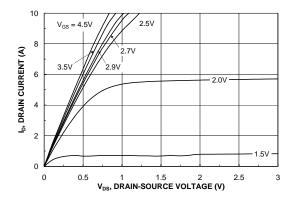


Figure 1. On-Region Characteristics.

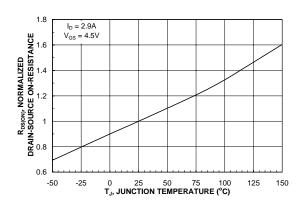


Figure 3. On-Resistance Variation with Temperature.

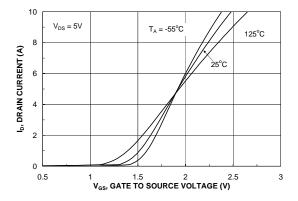


Figure 5. Transfer Characteristics.

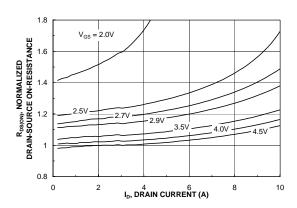


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

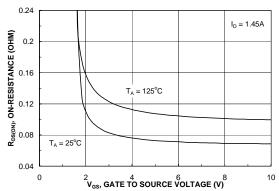


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

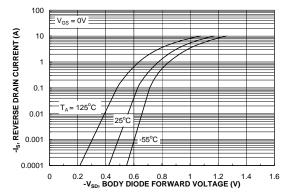
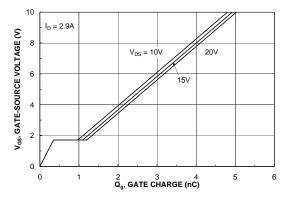


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

# **Typical Characteristics**



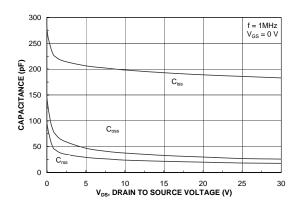
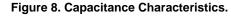
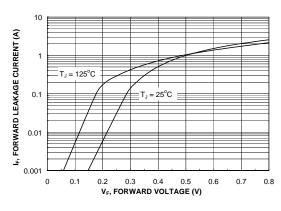


Figure 7. Gate Charge Characteristics.





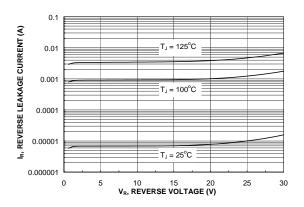


Figure 9. Schottky Diode Forward Voltage.

Figure 10. Schottky Diode Reverse Current.

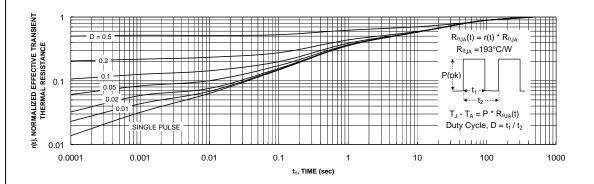
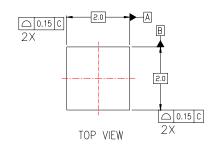
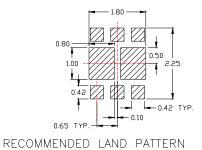
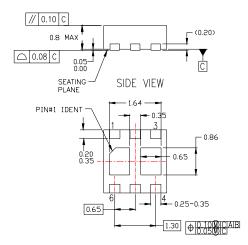


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.







BOTTOM VIEW

### NOTES:

- A. CONFORMS TO JEDEC REGISTRATION MO-229, VARIATION VCCC, DATED 11/2001
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994

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